

ITS41k0S-ME-N

Smart High-Side NMOS-Power Switch

Data Sheet

Rev 1.0, 2012-09-01

Standard Power



Smart High-Side NMOS-Power Switch

ITS41k0S-ME-N



1 Overview

Features

- Current controlled input
- Capable of driving all kind of loads (inductive, capacitive and resitive)
- Negative voltage clamped at output with inductive loads
- Current limitation
- · Very low standby current
- Thermal shutdown with restart
- Overload protection
- Short circuit protection
- Overvoltage protection (including load dump)
- Reverse battery protection
- Loss of GND and loss of Vbb protection
- ESD-Protection
- Improved electromagnetic compatibility (EMC)
- Green Product (RoHS compliant)

ITS41k0S-ME-N is not qualified and manufactured according to the requirements of Infineon Technologies with regards to automotive and/or transportation applications.

Description

The ITS41k0S-ME-N is a protected 1 Ω single channel Smart High-Side NMOS-Power Switch in a PG-SOT223-4 package with charge pump and current controlled input, monolithically integrated in a smart power technology.

Product Summary

Overvoltage protection $V_{SAZ min}$ = 62V Operating voltage range 4,9V < V_S < 60V On-state resistance R_{DSON} typ 800 m Ω Operating Temperature range Tj = -40°C to 125°C

Application

- · All types of resistive, inductive and capacitive loads
- Current controlled power switch for 12V, 24V and 45V DC in industrial applications
- Driver for electromagnetic relays
- Signal amplifier

Туре	Package	Marking
ITS41k0S-ME-N	PG-SOT223-4	I1k0SN

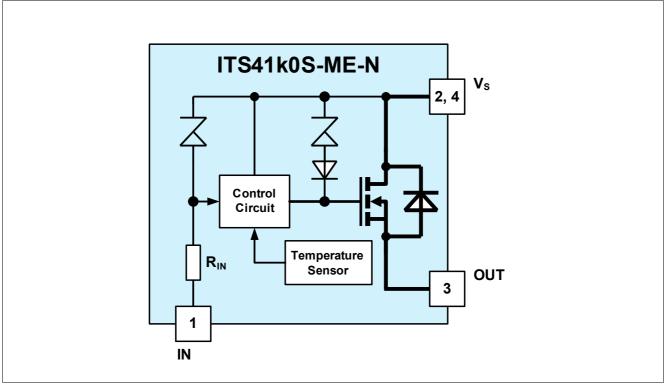


PG-SOT223-4



Block Diagram and Terms

2 Block Diagram and Terms





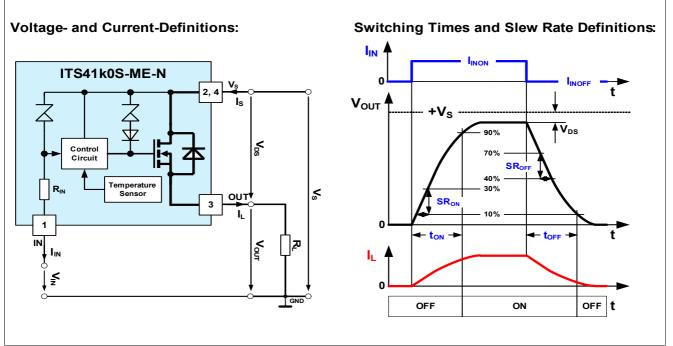


Figure 2 Terms - parameter definition



Pin Configuration

3 Pin Configuration

3.1 Pin Assignment

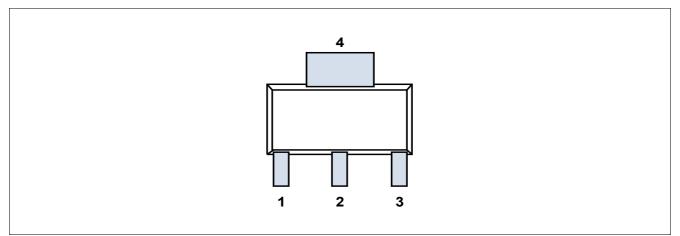


Figure 3 Pin configuration top view, PG-SOT223-4

3.2 Pin Definitions and Functions

Pin	Symbol	Function
1	IN	Input, activates the power switch in case of connection to GND
2	VS	Supply voltage
3	OUT	Output to the load
4	VS	Supply voltage



General Product Characteristics

4 General Product Characteristics

4.1 Absolute Maximum Ratings

Table 1Absolute maximum ratings $^{1)}Tj = 25^{\circ}C$ all voltages with respect to ground.

Currents flowing into the device unless otherwise specified in chapter "Block Diagram and Terms"

Parameter	Symbol		Values	Unit	Note /	
		Min.	Тур.	Max.	1	Test Co ndition
Supply voltage VS						
Voltage	Vs		60	V		4.1.1
Output stage OUT					+	
Output Current; (Short circuit current see electrical characteristics)	I _{OUT}	self limi	ited		A	4.1.2
Input IN	I					
Input Current	I IN	-15	15	mA		4.1.3
Temperatures	I		ш			
Junction Temperature	$T_{\rm j}$	-40	125	°C		4.1.4
Storage Temperature	T _{stg}	-55	125	°C		4.1.5
Power dissipation			ш			
Ta = 25 °C ²⁾	P _{tot}		1.7	W		4.1.6
Inductive load switch-off energy dissipa	tion					
Tj = 150 °C; IL=0.15A; single pulse $^{1)}$	E _{AS}		1000	mJ		4.1.7
ESD Susceptibility	I	I	I			
ESD susceptibility (input pin)	V_{ESD}	-1	1	kV	HBM ³⁾	4.1.8
ESD susceptibility (all other pins)	V_{ESD}	-5	5	kV	HBM ³⁾	4.1.9
1) Not subject to production test specified by		1	1	1	1	1

1) Not subject to production test, specified by design

Device on 50mm*50mm*1.5mm epoxy PCB FR4 with 6 cm2 (one layer, 70mm thick) copper area for Vbb connection. PCB is vertical without blown air

3) ESD susceptibility HBM according to EIA/JESD 22-A 114.

Note: Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" the normal operating range. Protection functions are not designed for continuous or repetitive operation.



General Product Characteristics

4.2 Functional Range

Table 2Functional Range

Parameter	Symbol	Values		Values		Unit	Note /	Number
		Min.	Тур.	Max.		Test Condition		
Nominal Operating Voltage	Vs	4.9	-	60	V	$V_{\rm S}$ increasing	4.2.1	

Note: Within the functional range the IC operates as described in the circuit description. The electrical characteristics are specified within the conditions given in the related electrical characteristics table.

4.3 Thermal Resistance

This thermal data was generated in accordance with JEDEC JESD51 standards.

More information on www.jedec.org.

Table 3Thermal Resistance1)

Parameter	Symbol	Values			Unit	Note /	Number
		Min.	Тур.	Max.		Test Condition	
PG-SOT223-4			-+	1	1		1
Junction to Case, Exposed pad	R _{thic}	-	40.5	-	K/W		4.3.1
Junction to ambient	R _{thJA_1s0p}	-	145.4	-	K/W	2)	4.3.2
Junction to ambient	R _{thJA_1s0p_300mm}	-	77.2	-	K/W	3)	4.3.3
Junction to ambient	R _{thJA_1s0p_600mm}	-	66.2	-	K/W	4)	4.3.4
Junction to ambient	R _{thJA_2s2p}	-	57.8	-	K/W	5)	4.3.5
	R _{thJA_2s2pvia}	-	52.9	-	K/W	6)	4.3.6

1) Not subject to production test, specified by design

 Specified R_{thJA} value is according to Jedec JESD51-3 at natural convection on FR4 1s0p board, footprint; the Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 1x 70µm Cu.

 Specified R_{thJA} value is according to Jedec JESD51-3 at natural convection on FR4 1s0p board, Cu, 300mm²; the Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 1x 70μm Cu.

 Specified R_{thJA} value is according to Jedec JESD51-3 at natural convection on FR4 1s0p board, 600mm²; the Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 1x 70μm Cu.

5) Specified *R*_{thJA} value is according to Jedec JESD51-2,-5,-7 at natural convection on FR4 2s2p board; the Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 2 inner copper layers (2 x 70µm Cu, 2 x 35µm Cu).

6) Specified R_{thJA} value is according to Jedec JESD51-2,-5,-7 at natural convection on FR4 2s2p board with two thermal vias; the Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 2 inner copper layers (2 x 70µm Cu, 2 x 35µm Cu. The diameter of the two vias are equal 0.3mm and have a plating of 25um with a copper heatsink area of 3mm x 2mm). JEDEC51-7: The two plated-through hole vias should have a solder land of no less than 1.25 mm diameter with a drill hole of no less than 0.85 mm diameter.



Electrical Characteristics

5 Electrical Characteristics

Table 4Vs = 9V to 60V; Tj = -40°C to 125°C; all voltages with respect to ground. Currents flowing into
the device unless otherwise specified in chapter "Block Diagram and Terms". Typical values
at Vs = 13.5V, Tj = 25°C

Parameter	Symbol	Values			Unit	Note /	Number
		Min. Typ. Ma		Max.	_	Test Condition	
Powerstage	I						
NMOS ON Resistance	R _{DSON}	_	0.8	1.5	Ω	I_{OUT} = 150mA; T_{j} = 25°C; IN conected to GND	5.0.1
NMOS ON Resistance	R _{DSON}	-	1.5	3.0	Ω	I_{OUT} = 150mA; T_{j} = 125°C; IN conected to GND	5.0.2
NMOS ON Resistance	R _{DSON}	-	2	5	Ω	I_{OUT} = 50mA; T_{j} = 25°C; V_{S} = 6V; IN conected to GND	5.0.3
Nominal Load Current ¹⁾ ; device on PCB ²⁾	I _{LNOM}	0.2	-	-	A	$T_{a} = 85^{\circ}C;$ $T_{j} = 125^{\circ}C;$	5.0.4
Timings of Power Stages	<u> </u>		<u> </u>				
Turn ON Time ³⁾ (to 90% of V_{out}); V_{S} to GND transition of V_{IN}	t _{ON}	-	-	125 ⁴⁾	μs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 270 Ω	5.0.5
Turn ON Time ³⁾ (to 90% of V_{out}); V_{S} to GND transition of V_{IN}	t _{ON}	-	45	100	μs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 270Ω; $T_{\rm I}$ = 25°C	5.0.6
Turn OFF Time ³⁾ (to 10% of V_{out}); GND to V_{S} transition of V_{IN}	t _{OFF}	-	-	175 ⁴⁾	μs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 270 Ω	5.0.7
Turn OFF Time ³⁾ (to 10% of V_{out}); GND to V_{S} transition of V_{IN}	t _{OFF}	-	40	140	μs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 270Ω; $T_{\rm i}$ = 25°C	5.0.8
ON-Slew Rate ³⁾ (10 to 30% of V_{out}); V_{S} to GND transition of V_{IN}	SR _{ON}	-	-	6 ⁴⁾	V / µs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 270 Ω	5.0.9
ON-Slew Rate ³⁾ (10 to 30% of V_{out}); V_{s} to GND transition of V_{IN}	SR _{ON}	-	1.3	4.0	V/µs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 270Ω; $T_{\rm i}$ = 25°C	5.0.10
OFF-Slew Rate ³⁾ (70 to 40% of V_{out}); GND to V_{S} transition of V_{IN}	SR _{OFF}	-	-	8 4)	V/µs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 270 Ω	5.0.11
OFF-Slew Rate ³⁾ (70 to 40% of V_{out}); GND to V_{S} transition of V_{IN}	SR _{OFF}	-	1.7	4.0	V/µs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 270Ω; $T_{\rm i}$ = 25°C	5.0.12
Standby current consumption	I	1	I	I	l		1

Data Sheet



Electrical Characteristics

Table 4Vs = 9V to 60V; Tj = -40°C to 125°C; all voltages with respect to ground. Currents flowing into
the device unless otherwise specified in chapter "Block Diagram and Terms". Typical values
at Vs = 13.5V, Tj = 25°C

Parameter	Symbol		Values			Note /	Number
		Min.	Тур.	Max.		Test Condition	
Standby current	$I_{\rm SOFF}$	-	2	10	μA	IN open	5.0.13
Protection functions ⁵⁾	4	1					
Initial peak short circuit current limit IN conected to GND	I _{LSCP}	-	-	1.2	A	$T_{\rm j}$ = -40°C; $V_{\rm S}$ = 13.5V $t_{\rm m}$ = 100µs	5.0.14
Initial peak short circuit current limit IN conected to GND	I _{LSCP}	-	0.9	-	A	$T_{\rm j}$ = 25°C; $V_{\rm S}$ = 13.5V $t_{\rm m}$ = 100µs	5.0.15
Initial peak short circuit current limit IN conected to GND	I _{LSCP}	0.2	-	-	A	$T_{\rm j}$ =125°C; $V_{\rm S}$ = 13.5V $t_{\rm m}$ = 100µs	5.0.16
Repetitive short circuit current limit IN conected to GND	ILSCR	-	0.7	-	A	_	5.0.17
Output clamp at $V_{OUT} = V_{S} - V_{DSCL}$ (inductive load switch off)	V _{DSCL}	60	-	-	V	I _S = 4mA	5.0.18
Overvoltage protection	V _{SAZ}	62	68	-	V	<i>I</i> _S = 1mA	5.0.19
Thermal overload trip temperature ⁴⁾	$T_{\rm jTrip}$	150	-	-	°C	-	5.0.20
Thermal hysteresis 4)	T _{HYS}		10	_	°C	-	5.0.21
Input interface	1						
Off state input current	I _{INOFF}	-	-	0.05	mA	$T_{\rm j}$ = -25°C; $R_{\rm L}$ = 270Ω; $V_{\rm OUT}$ =< 0.1V	5.0.22
Off state input current	I _{INOFF}	-	-	0.04	mA	$T_{\rm j}$ = 125°C; $R_{\rm L}$ = 270Ω; $V_{\rm OUT}$ =< 0.1V	5.0.23
On state input current; IN connected to GND ⁶⁾	I _{INON}	-	0.3	1.0	mA	-	5.0.24
Input resistance	R _{IN}	0.5	1.0	2.5	kΩ	-	5.0.25
Reverse Battery	<u> </u>	+	I	I	!	ł	I
Continuous reverse drain current	I_{DREV}	-	-	0.2	А	-	5.0.26
Forward voltage of the drain-source reverse diode	V _{FDS}	-	600	-	mV	I _{FDS} = 200mA I _{IN} =< 0.05mA	5.0.27

1) Nominal Load Current is limited by the current limitation; see protection function data

2) Device on 50mm x 50mm x 1,5mm epoxy FR4 PCB with 6cm² (one layer copper 70um thick) copper area for supply voltage connection. PCB in vertical position without blown air

3) Timing values only with high input slewrates ($t_{rIN} = t_{fIN} \le 50$ ns); otherwise slower

4) Not tested in production

 Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" normal operating range. Protection functions are not designed for continuous repetitive operation.

6) Driver circuit must be able to sink currents > 1mA



Application Information

6 Application Information

6.1 Application Diagram

The following information is given as a hint for the implementation of the device only and shall not be regarded as a description or warranty for a certain functionality, condition or quality of the device.

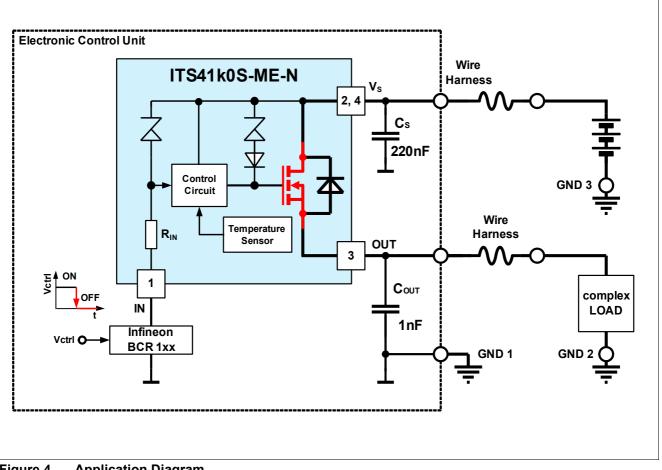


Figure 4 Application Diagram

The **ITS41k0S-ME-N** can be connected directly to a supply network. It is recommended to place a ceramic capacitor (e.g. $C_{\rm S}$ = 220nF) between supply and GND to avoid line disturbances. Wire harness inductors/resistors are sketched in the application circuit above.

The complex load (resistive, capacitive or inductive) must be connected to the output pin OUT.

A built-in current limit protects the device against destruction.

The ITS41k0S-ME-N can be switched on and off with a low power levelshifter switch e.g. Infineon BCR1xx.

The IN pin must be pulled down to GND potential to switch the **ITS41k0S-ME-N** on. If no current is pulled down, the IN-node will float up to $V_{\rm S}$ potential by an internal pull up. In this mode the **ITS41k0S-ME-N** is deactivated with very low current consumption.

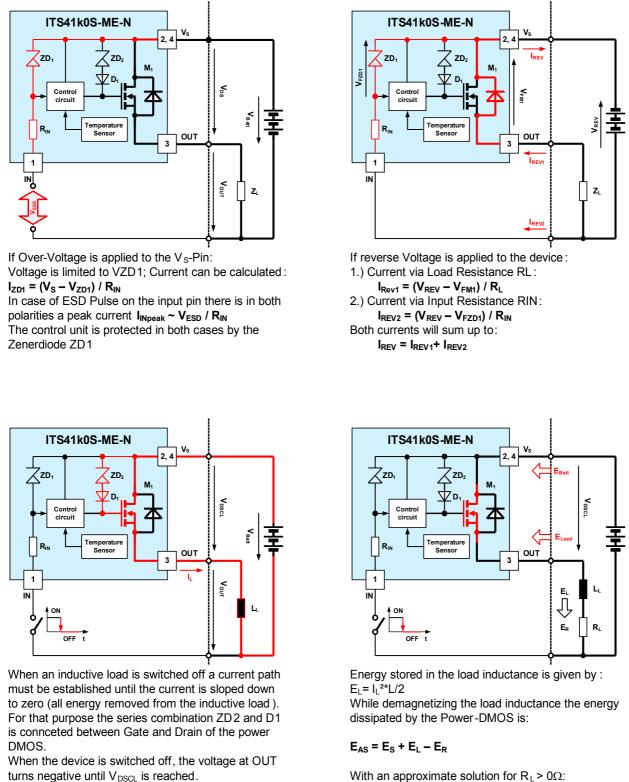
The output voltage slope is controlled during on and off transistion to minimize emissions. Only a small Cercap C_{OUT} =1nF is recommended to attenuate RF noise.

In the following chapters the main features, some typical waverforms and the protection behaviour of the **ITS41k0S-ME-N** is shown. For further details please refer to application notes on the Infineon homepage.



Application Information

6.2 Special features



The Voltage on the incutive load is the difference between V_{DSCL} and V_{S} .



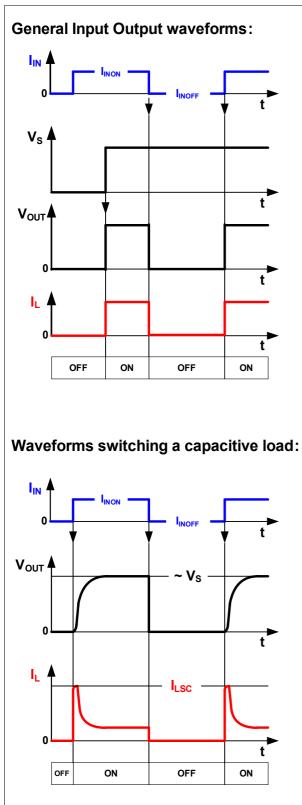
 $E_{AS} = (I_L*L) / (2*R_L)*(V_S+V_{DSCL})*In((1+(I_L*R_L) / V_{DSCL}))$



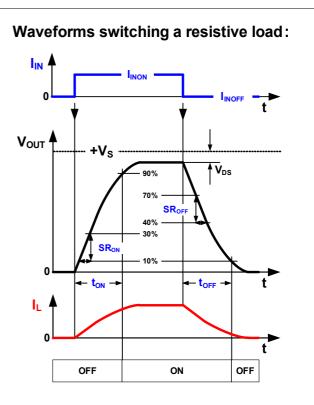
infineon

Application Information

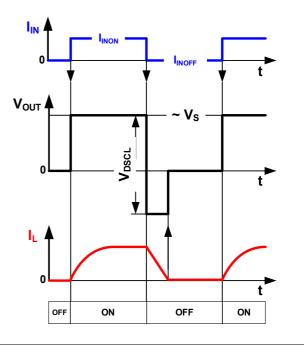
6.3 Typical Application Waveforms







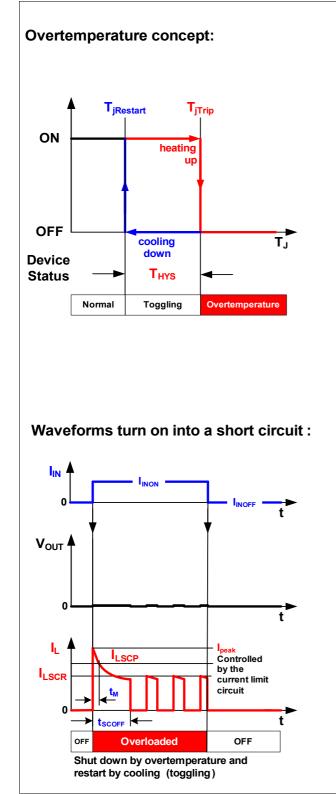




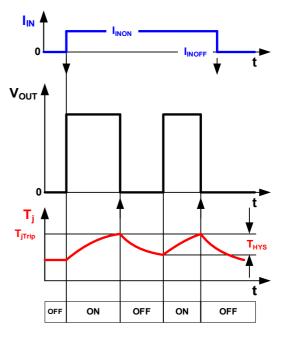


Application Information

6.4 **Protection behavior**



Overtemperature behavior



Waveforms short circuit during on state :

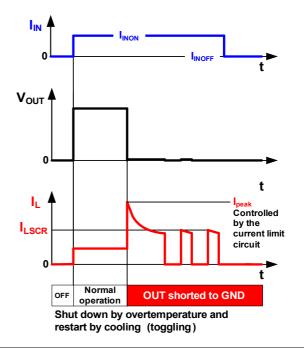


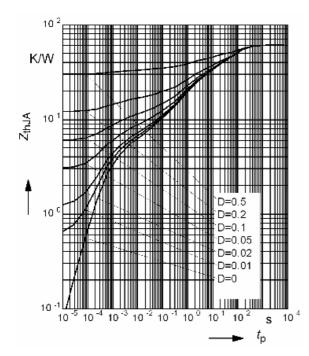
Figure 7 Protective behaviour waveforms of the ITS41k0S-ME-N



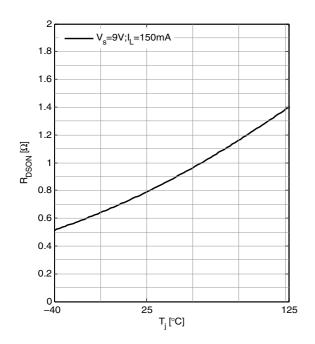


Typical Performance Characteristics

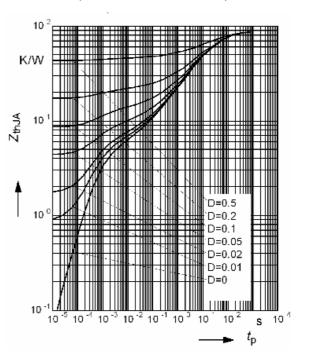
Transient Thermal Impedance Z_{thJA} versus Pulse Time t_p @ 6cm² heatsink area (D= t_p/T)



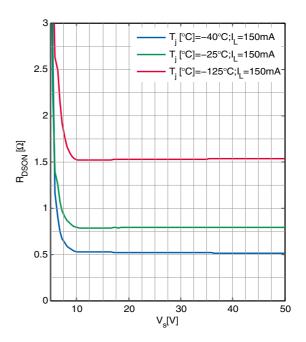
On-Resistance R_{DSON} versus Junction Temperature T_J @ = V_S = 9V; I_L =150mA



Transient Thermal Impedance Z_{thJA} versus Pulse Time t_p @ min. footprint (D= t_p /T)



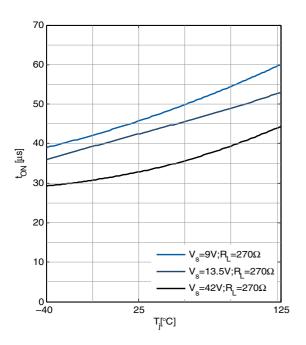
On-Resistance R_{DSON} versus Supply Voltage $V_{\text{S}} = V_{\text{bb}} @= I_{\text{L}} = 150 \text{mA} T_{\text{i}} = \text{par.}$



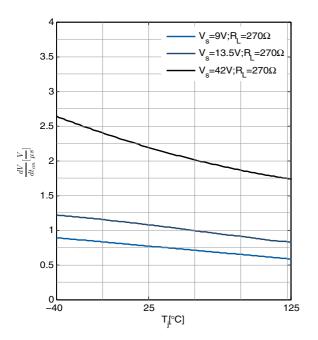


Typical Performance Characteristics

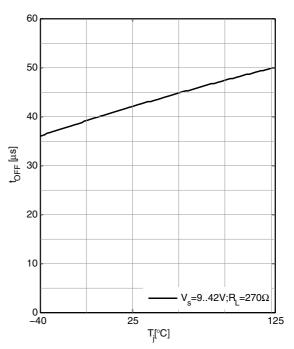
Switch ON Time t_{ON} versus Junction Temperature T_J @ = R_L = 270 Ω ; V_S = par.



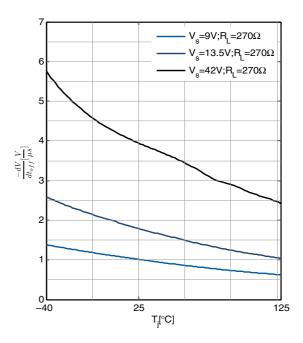
ON Slewrate SR_{ON} versus Junction Temperature T_J @ = R_L = 270 Ω ; V_S = par.



Switch OFF Time t_{OFF} versus Junction Temperature T_J @ = R_L = 270 Ω ; V_S = par.



OFF Slewrate SR_{OFF} versus Junction Temperature T_J @ = R_L = 270 Ω ; V_S = par.

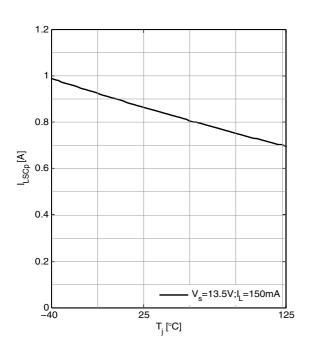




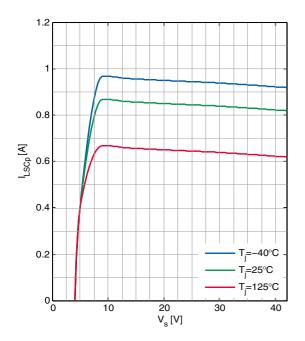


Typical Performance Characteristics

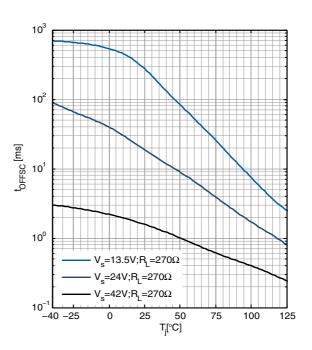
Initial Peak Short Circuit Current Limit I_{LSCP} versus Junction Temperature $T_J @ V_S = 13.5V$; $t_m = 100 \mu s$



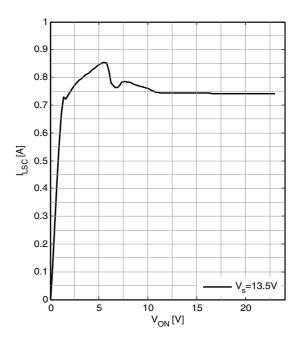
Initial Peak Short Circuit Current Limit I_{LSCP} versus Supply Voltage $V_{S} = V_{bb} @ T_{j}$ =par.= 100µs.



Initial Short Circuit Shutdown Time $t_{\text{OFF SC}}$ versus Junction Start-Temperature T_{JSTART} ; V_{S} =parameter



Current Limitation Characteristic I_{LSC} versus Drain Source Voltage Drop V_{DS} @ V_{S} =13.5 V

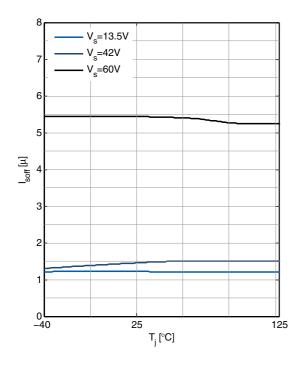






Typical Performance Characteristics

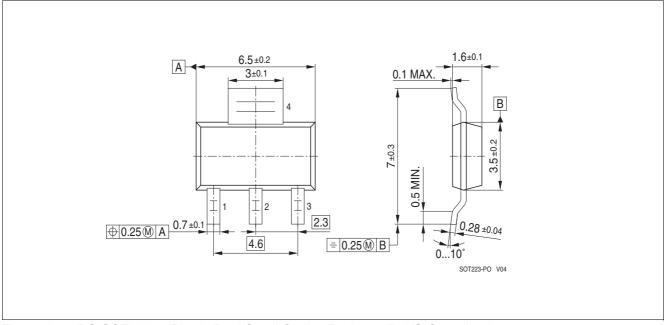
Stand By Current Consumption I_{SOFF} versus Junction Temperature T_J @ pin IN open

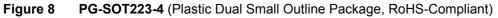




Package Outlines and Footprint

8 Package Outlines and Footprint





To meet the world-wide customer requirements for environmentally friendly products and to be compliant with government regulations the device is available as a green product. Green products are RoHS-Compliant (i.e Pb-free finish on leads and suitable for Pb-free soldering according to IPC/JEDEC J-STD-020



Revision History

9 Revision History

Revision	Date	Changes
1.0	2012-09-01	Datasheet release

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Information

For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (www.infineon.com).

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